

## Defining acceptance limits for Ni-AM powder using materials simulation

Caspar Schwalbe, Magdalena Futoma, Thomas Göhler, Andreas Fischersworring-Bunk

MTU Aero Engines AG

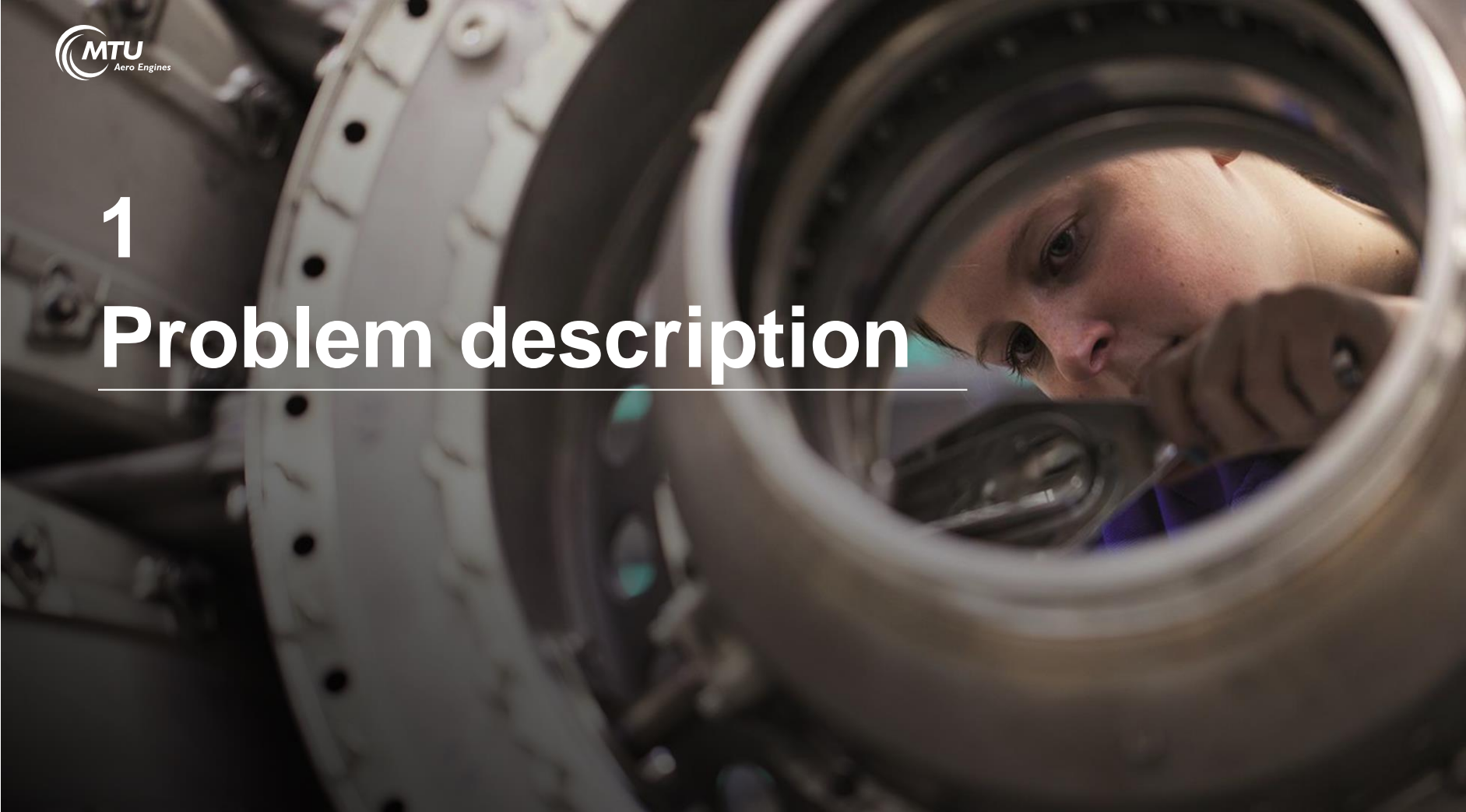
EASA-FAA AM Event (Day 3)

10.11.2021

# 1

# Problem description

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### Contamination of Ni-AM powders

**Two types of contaminants** regularly occur  
in the standard processing cycle

**Residual AM-powder**  
from a previous job

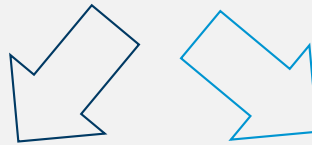


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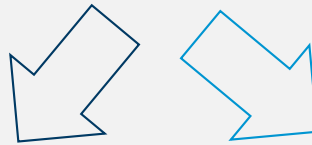
**Non AM-powder contaminants**  
(e.g. metal chips)

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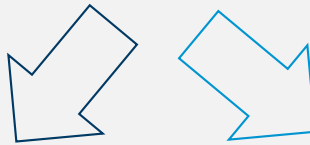
**Problem:** The foreign powder might **change the local chemistry** and thus alter **local properties of the part**

## Problem description

### Contamination of Ni-AM powders

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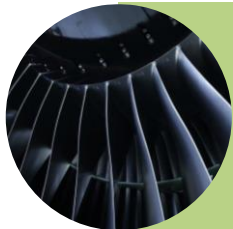
**Residual AM-powder**  
from a previous job



**Non AM-powder contaminants**  
(e.g. metal chips)



**Problem:** The foreign powder might **change the local chemistry** and thus alter **local properties of the part**



#### **Approach:**

1. Classify the contaminant and determine its abundance
2. Calculate the dilution factor
3. Determine if the contamination results in a lifing debit



# 2

# Contamination classification

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## Classification of the contamination in the standard workflow

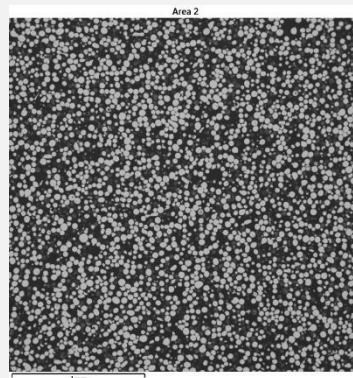
### Detection of contaminants

Routine powder inspection is carried out to determine presence and composition of contaminations.

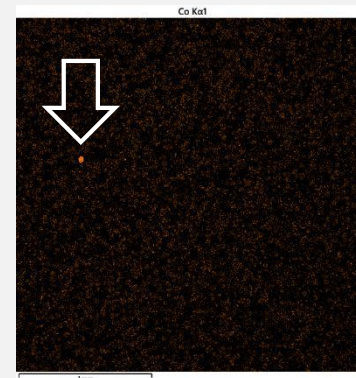


e.g. Co particles

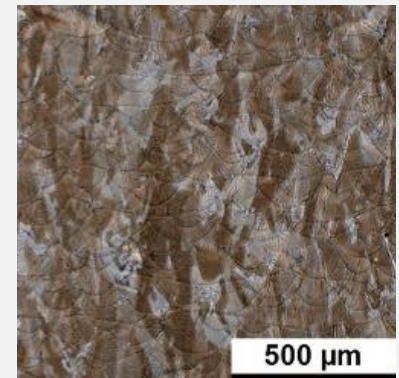
SEM  $\mu$ -graph



Contaminant detection



LM post build





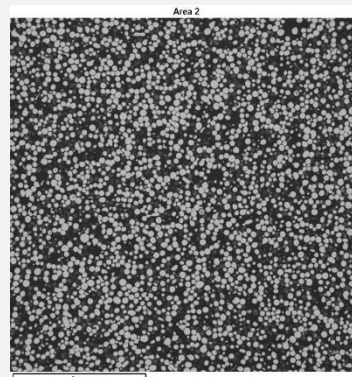
## Classification of the contamination in the standard workflow

### Detection of contaminants

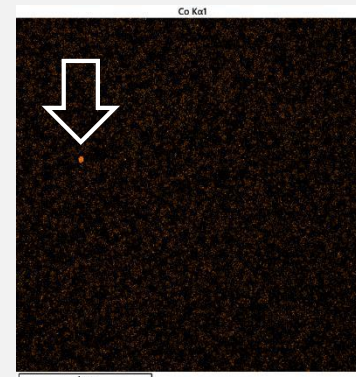
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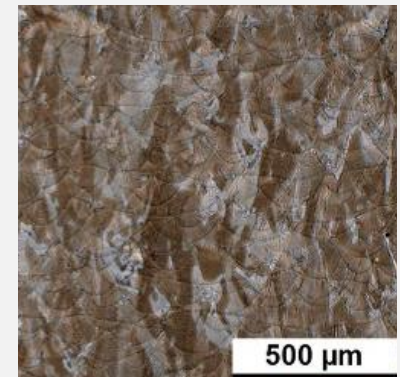
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Contaminant detection



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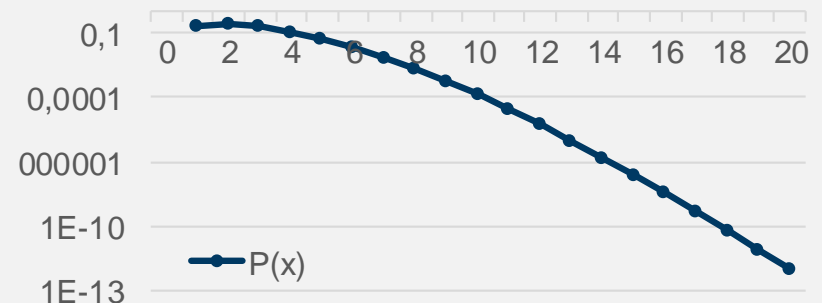
### Estimating prevalence of contamination

Assuming a spherical powder shape and a Poisson law for the distribution of contaminants the likelihood of any number of contaminant particles per imaged area is calculated.

➡ e.g. Likelihood of 2 Co particles per 10k ~27%

### Likelihood of Co-Al particles per 10000 particles

$$P(x; \mu) = \frac{e^{-\mu} (\mu^x)}{x!}$$



# 3

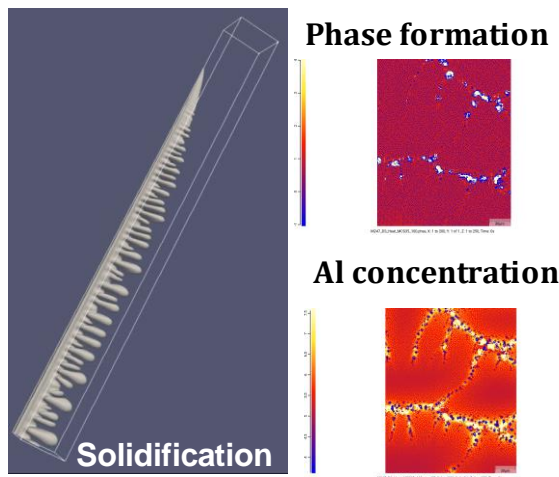
## Deriving acceptance criteria

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# Deriving acceptance criteria using materials simulation

## CC

Conventional casting results in a *dilution* of any contaminant particle through the *entire crucible*.



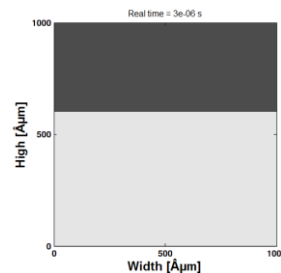
Softw are used: MICRESS; Licensed by Access e.V.

## AM

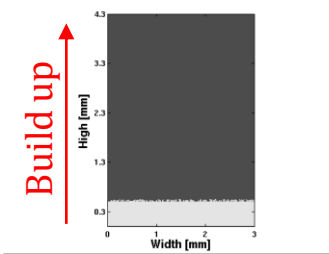
We need to simulate the AM process on a *local scale* to gather key information :

- How large is the meltpool ?
  - How many layers are re-melted with each pass ?
  - What are the melt flow dynamics ?
- **How large is the dilution factor ?**

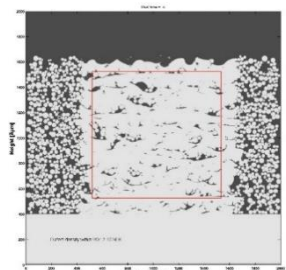
A single meltpool



AM build-up



Completed job

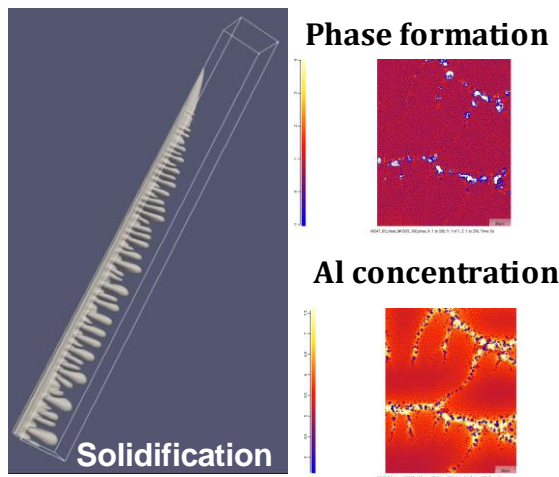


Softw are used: Sample2D; Licensed by FAU Erlangen

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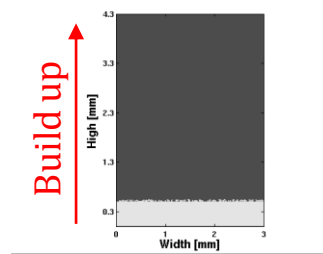
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## AM

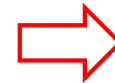
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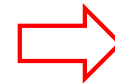
AM build-up



Softw are used: MELB; Licensed by FAU Erlangen



e.g. 500 particles in meltpool from up to 4 re-melt layers



dilution factor < 1:500





Thank you for your attention!

## References

**MICRESS** is a product of ACCESS e.V.

**ThermoCalc** is a product of ThermoCalc SE

**Sample 2D** and **MELB** are products of the University of Erlangen-Nuremberg

**ABAQUS** is a product of Dassault Systems